


<b>Search Notes</b> 	<b>Application/Control No.</b> 10646531	<b>Applicant(s)/Patent Under Reexamination</b> LOVE ET AL.
	<b>Examiner</b> Chawan, Sheela C	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	224,303,132,149,154,308,305,284,286,260,209,124,	1/31/07	SCC
707	104.1,3	"	"
378	98.12	"	"
345	426,423,589	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, US-PGPUB,USPAT,EPO,JPO,DERWENT,IBM-TDB.	1/31/07	SCC
INVENTOR NAME SEARCH.	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner